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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): AOKI	Atty. Dkt.: 01-562
Serial No.: 10/790,211	Group Art Unit: 2811
Filed: March 2, 2004	Examiner: Unknown
Title: SEMICONDUCTOR DEVICE HAVING TRENCH GATE STRUCTURE AND METHOD FOR MANUFACTURING THE SAME	



Commissioner for Patents
Alexandria, VA 22314

Date: July 19, 2005

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference listed on the attached Form PTO-1449 is being brought to the attention of the Examiner without any admission that it constitutes statutory prior art, or without any admission that it contains subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference was first cited in a Communication (copy enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

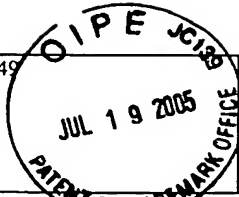
Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed references have been considered and made of record.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "D. G. Posz".

David G. Posz
Reg. No. 37,701

Posz Law Group, PLC
12040 South Lakes Drive
Suite 101
Reston, VA 20191
(703) 707-9110 (phone)
Customer No. 23400

FORM PTO-1449				* PATENT APPLICATION Page 1 of 1	
ATTY. DKT NO.		01-562		SER. NO. 10/790,211	
APPLICANT		ISAJI et al.			
FILING DATE		November 16, 2004		GROUP 2811	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
		6,465,325	10/15/02	Ridley et al.		

FOREIGN PATENT DOCUMENTS

									TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED	